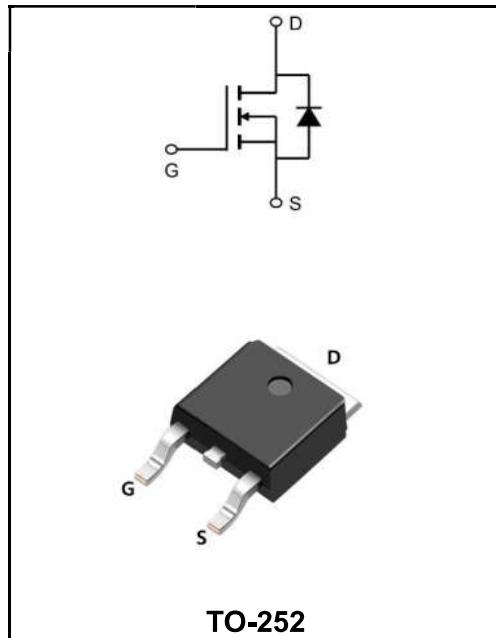


**80V N-CHANNEL ENHANCEMENT MODE MOSFET**
**MAIN CHARACTERISTICS**

$I_D$	100A
$V_{DSS}$	80V
$R_{DS(on)-typ}(@V_{GS}=10V)$	< 6.8mΩ (Type: 5.5 mΩ)


**Applications**

- ◆ Battery protection
- ◆ Load switch
- ◆ Uninterruptible power supply

**Product Specification Classification**

Part Number	Package	Marking	Pack
YFW100N08AD	TO-252	YFW 100N08AD XXXXX	2500PCS/Tape

**Maximum Ratings at  $T_c=25^\circ\text{C}$  unless otherwise specified**

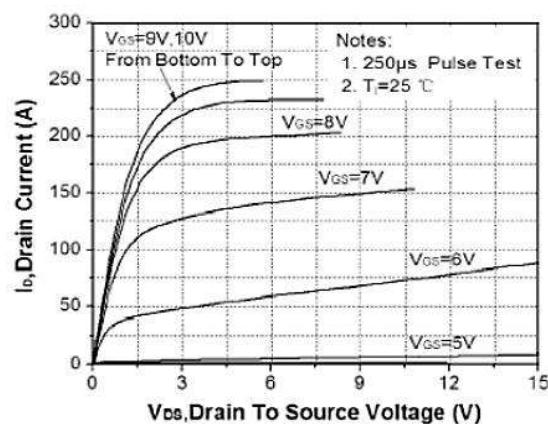
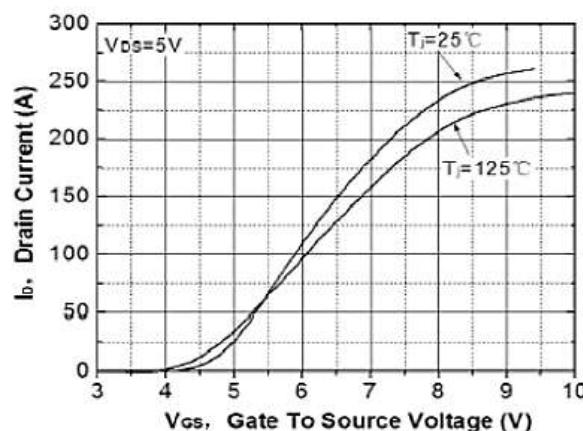
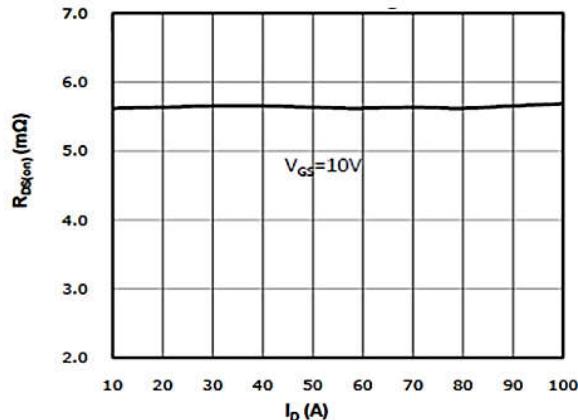
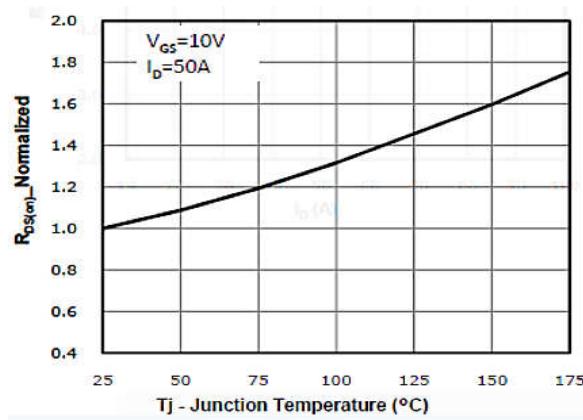
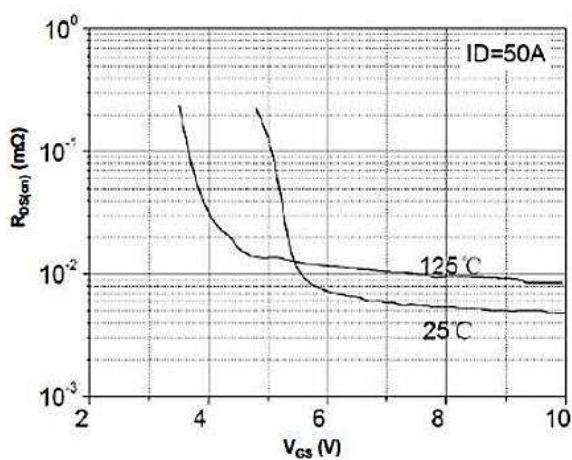
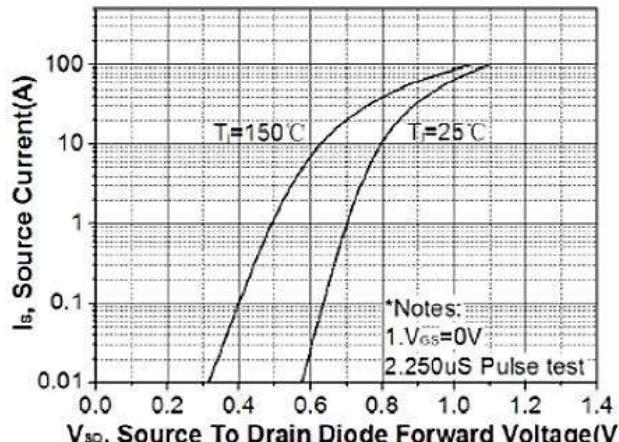
Characteristics	Symbols	Value	Units
Drain-Source Voltage	$V_{DS}$	80	V
Gate - Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current, $V_{GS} @ 10V^{1,6}$ @ $T_c=25^\circ\text{C}$	$I_D$	100	A
Continuous Drain Current , $V_{GS} @ 10V^{1,6}$ @ $T_c=100^\circ\text{C}$	$I_D$	60	A
Pulsed Drain Current <sup>2</sup>	$I_{DM}$	400	A
Single Pulse Avalanche Energy <sup>3</sup>	$E_{AS}$	506	mJ
Total Power Dissipation <sup>4</sup> @ $T_c=25^\circ\text{C}$	$P_D$	158	W
Storage Temperature Range	$T_{STG}$	-55 to +150	°C
Operating and Storage Temperature Range	$T_J$	-55 to +150	°C
Thermal Resistance Junction-Ambient <sup>1</sup>	$R_{\theta JA}$	92	°C/W
Thermal Resistance Junction-Case <sup>1</sup>	$R_{\theta JC}$	1.22	°C/W

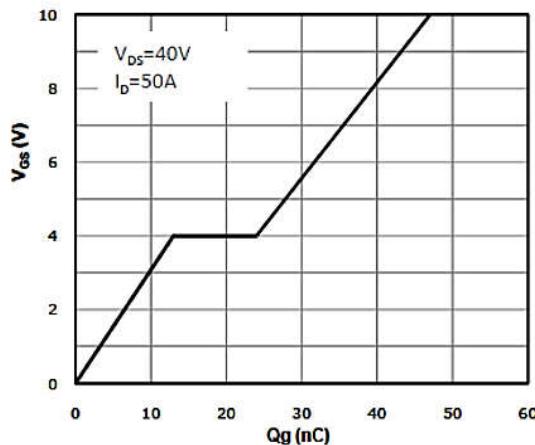
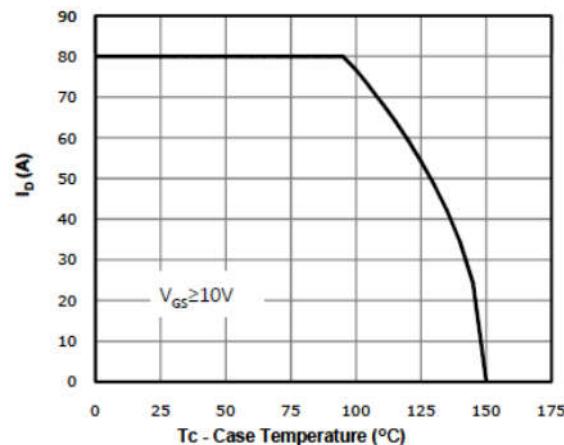
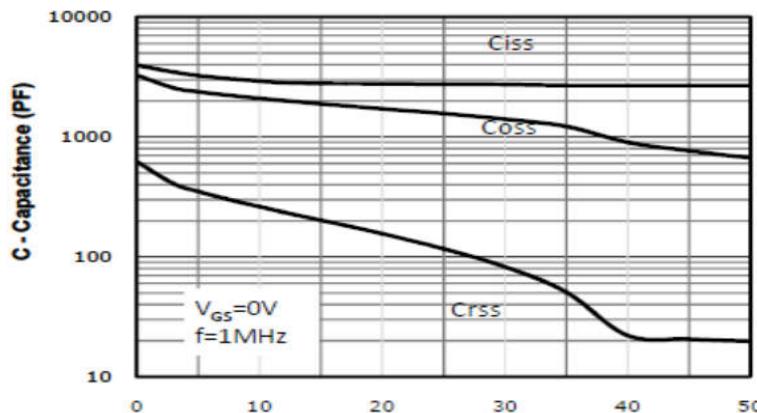
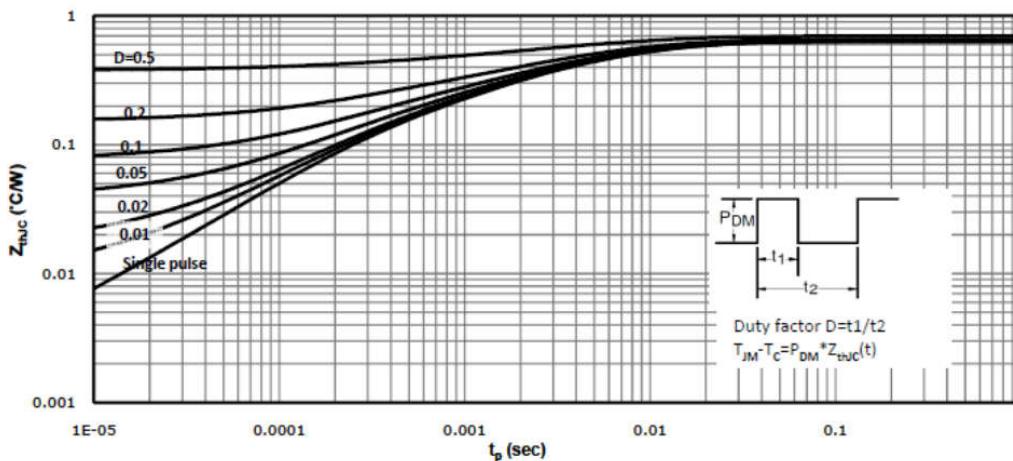
**Maximum Ratings at T<sub>c</sub>=25°C unless otherwise specified**

Characteristics	Test Condition	Symbols	Min	Typ	Max	Units
Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	BV <sub>DSS</sub>	80	92	-	V
Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V, I <sub>D</sub> =50A	R <sub>DSON</sub>	-	5.5	6.8	mΩ
Gate -Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	V <sub>GS(th)</sub>	2.0	3.0	4.0	V
Drain-Source Leakage Current	V <sub>DS</sub> =80V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C	I <sub>DSS</sub>	-	-	1	μA
	V <sub>DS</sub> =80V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C		-	-	5	
Gate- Source Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	I <sub>GSS</sub>	-	-	±100	nA
Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =20A	g <sub>f</sub>	-	75	-	S
Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz	R <sub>g</sub>	-	2.0	-	Ω
Total Gate Charge(10V)	V <sub>DS</sub> =40V V <sub>GS</sub> =10V I <sub>D</sub> =20A	Q <sub>g</sub>	-	56.6	-	nC
Gate-Source Charge		Q <sub>gs</sub>	-	21.4	-	
Gate-Drain Charge		Q <sub>gd</sub>	-	12.5	-	
Turn-on delay time	V <sub>DD</sub> =40V V <sub>GS</sub> =10V R <sub>G</sub> =3Ω I <sub>D</sub> =20A	t <sub>d(on)</sub>	-	17.3	-	ns
Rise Time		T <sub>r</sub>	-	33	-	
Turn-Off Delay Time		t <sub>d(OFF)</sub>	-	38.9	-	
Fall Time		t <sub>f</sub>	-	18.1	-	
Input Capacitance	V <sub>DS</sub> =40V V <sub>GS</sub> =0V f=1MHz	C <sub>iss</sub>	-	3475	-	pF
Output Capacitance		C <sub>oss</sub>	-	770	-	
Reverse Transfer Capacitance		C <sub>rss</sub>	-	25	-	
Continuous Source Current <sup>1,5</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current	I <sub>s</sub>	-	-	100	A
Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>s</sub> =A , T <sub>J</sub> =25°C	V <sub>SD</sub>	-	0.9	1.3	V
Reverse Recovery Time	I <sub>F</sub> =20A , dI/dt=100A/μs , T <sub>J</sub> =25°C	t <sub>rr</sub>	-	68	-	ns
Reverse Recovery Charge		Q <sub>rr</sub>	-	66	-	nC

Note :

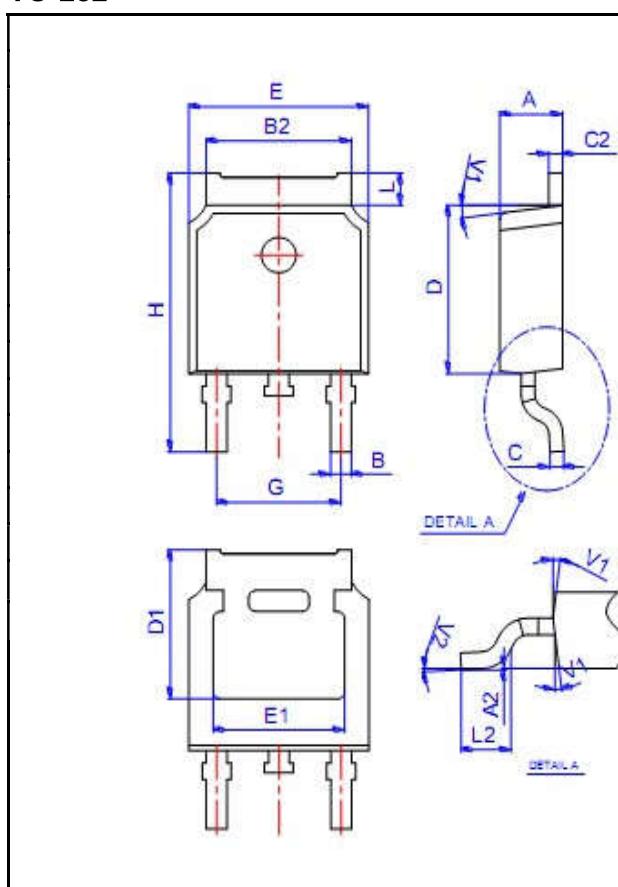
- 1、The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2、The data tested by pulsed , pulse width .The EAS data shows Max. rating .
- 3、The test cond ≤ 300us duty cycle ≤ 2%, duty cycle ition is VDD=64VGS=10V,L=0.1mH,IAS=40A
- 4、The power dissipation is limited by 175°C junction temperature
- 5、The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

**Ratings and Characteristic Curves**
**Typical Characteristics**

**Figure 1. Typ. Output Characteristics (T<sub>j</sub>=25 °C)**

**Figure 2. Transfer Characteristics**

**Figure 3. On-Resistance vs. Drain Current and Gate Voltage Figure**

**Figure 4. On-Resistance vs. Junction Temperature**

**Figure 5. On-Resistance vs. Gate-Source Voltage**

**Figure 6 . Body-Diode Characteristics**

**Ratings and Characteristic Curves**

**Figure 7. Gate-Charge Characteristics**

**Figure 8. Drain Current Derating**

**Figure 9: Normalized Maximum Transient Thermal Impedance**

**Figure 10. Capacitance Characteristics**

**Package Outline Dimensions Millimeters**

**TO-252**



Dim.	Min.	Typ.	Max.
A	2.10	-	2.50
A2	0	-	0.10
B	0.66	-	0.86
B2	5.18	-	5.48
C	0.40	-	0.60
C2	0.44	-	0.58
D	5.90	-	6.30
D1	5.30REF		
E	6.40	-	6.80
E1	4.63	-	-
G	4.47	-	4.67
H	9.50	-	10.70
L	1.09	-	1.21
L2	1.35	-	1.65
V1	-	7°	-
V2	0°	-	6°

All Dimensions in millimeter